

| | | | | |
|-----------------------------------|---------------------------------------|--|--|-------------|
| Notice of References Cited | Application/Control No. 10/790,298 | | Applicant(s)/Patent Under Reexamination PHAN ET AL. | |
| | Examiner Thao X. Le | | Art Unit 2814 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|----------------------------|----------------|
| * | A | US-6,128,188 | 10-2000 | Hanners, John C. | 361/694 |
| * | B | US-6,729,383 | 05-2004 | Cannell et al. | 165/80.3 |
| * | C | US-6,952,050 | 10-2005 | Kwon et al. | 257/707 |
| * | D | US-6,098,408 | 08-2000 | Levinson et al. | 62/3.2 |
| * | E | US-5,940,784 | 08-1999 | El-Husayni, Hani A. | 702/130 |
| * | F | US-2005/0086948 | 04-2005 | Milke-Rojo et al. | 062/003.7 |
| * | G | US-5,867,990 | 02-1999 | Ghoshal, Uttam Shyamalindu | 62/3.7 |
| | H | US- | | | |
| | I | US- | | | |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.